

Search Notes



Application/Control No.

10/810,250

Examiner

Brandon W. Bowers

Applicant(s)/Patent under Reexamination

ZHANG, YOUPIING

Art Unit

2825

SEARCHED

Class	Subclass	Date	Examiner
716	19	4/13/05	BB
716	21	↓	↓

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
East	4/13/05	BB
IEEE (OK, Optical Proximity, bias, segment)	4/13/05	BB